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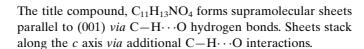
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Key indicators

Single-crystal X-ray study T = 180 K Mean σ (C–C) = 0.002 Å R factor = 0.042 wR factor = 0.121 Data-to-parameter ratio = 17.0

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

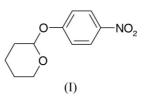


2-(p-Nitrophenoxy)tetrahydropyran

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Comment

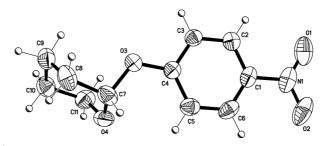
As part of a continuing study of the decomposition kinetics of 2-(p-nitrophenoxy)tetrahydropyran, (I), in amorphous saccharides, we have determined the crystal structure of (I) at 180 K. Compound (I) was synthesized by a modification of the procedure of Fife & Jao (1968) (see *Experimental*). Crystals of (I), as a racemic mixture, were obtained from its solution in hexane at room temperature.



The asymmetric unit of (I) consists of only one molecule. Two-dimensional networks (Fig. 2) perpendicular to the *c* axis are formed *via* C2–H2···O4 and C9–H9B···O2 hydrogen bonds (Table 1). These two-dimensional networks then stack along the *c* axis, linked by further C7–H7···O1 interactions.

Experimental

3,4-Dihydro-2*H*-pyran and *p*-nitrophenol were obtained from Aldrich and Avocado, respectively, and were used without further purification. Toluene, bought from Aldrich, was further dried over sodium wire. *p*-Nitrophenol (0.1 mol) was dissolved in dry toluene (100 ml) and an excess of 3,4 dihydro-2*H*-pyran (30 ml) was added to the solution. The resulting solution was stirred under reflux at 378 K for 3 d. The reaction mixture was then diluted with ether, followed by washing with 2% NaOH several times to remove the unreacted *p*-nitrophenol. The organic layer, dried over Na₂SO₄, was then filtered



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Figure 1 The molecule of (I), showing displacement ellipsoids at the 50% probability level.

organic papers

and evaporated. Crystals of (I) were obtained by dissolving the crude sample in hexane followed by slow evaporation at room temperature.

Crystal data

 $\begin{array}{l} C_{11}H_{13}NO_4 \\ M_r = 223.22 \\ Monoclinic, P2_1/c \\ a = 7.4772 \ (1) \ \text{\AA} \\ b = 21.9462 \ (4) \ \text{\AA} \\ c = 6.7828 \ (1) \ \text{\AA} \\ \beta = 102.491 \ (1)^\circ \\ V = 1086.69 \ (3) \ \text{\AA}^3 \\ Z = 4 \end{array}$

Data collection

Nonius KappaCCD diffractometer Thin-slice ω and φ scans Absorption correction: multi-scan (SORTAV; Blessing, 1995) $T_{\min} = 0.891, T_{\max} = 0.984$ 13336 measured reflections 2476 independent reflections

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.042$ $wR(F^2) = 0.121$ S = 1.082476 reflections 146 parameters H-atom parameters constrained
$$\begin{split} D_x &= 1.364 \text{ Mg m}^{-3} \\ \text{Mo } K\alpha \text{ radiation} \\ \text{Cell parameters from 12872} \\ \text{reflections} \\ \theta &= 1.0\text{-}27.5^{\circ} \\ \mu &= 0.11 \text{ mm}^{-1} \\ T &= 180 \text{ (2) K} \\ \text{Block, pale yellow} \\ 0.46 \times 0.23 \times 0.16 \text{ mm} \end{split}$$

1970 reflections with $I > 2\sigma(I)$ $R_{int} = 0.034$ $\theta_{max} = 27.5^{\circ}$ $h = -9 \rightarrow 9$ $k = -28 \rightarrow 28$ $l = -8 \rightarrow 8$

$$\begin{split} w &= 1/[\sigma^2(F_o^2) + (0.0567P)^2 \\ &+ 0.2284P] \\ \text{where } P &= (F_o^2 + 2F_c^2)/3 \\ (\Delta/\sigma)_{\text{max}} < 0.001 \\ \Delta\rho_{\text{max}} &= 0.35 \text{ e } \text{\AA}^{-3} \\ \Delta\rho_{\text{min}} &= -0.37 \text{ e } \text{\AA}^{-3} \\ \text{Extinction correction: } SHELXL97 \\ \text{Extinction coefficient: } 0.061 (8) \end{split}$$

Table 1 Hydrogen-bonding geometry (Å, °).

$D - H \cdots A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$
$C2-H2\cdots O4^{i}$	0.95	2.40	3.1783 (16)	139
$C7-H7\cdots O1^{ii}$	1.00	2.41	3.3956 (18)	170
$C9-H9B\cdots O2^{iii}$	0.99	2.52	3.2930 (19)	135
				,

Symmetry codes: (i) x - 1, y, z; (ii) 1 + x, $\frac{1}{2} - y$, $\frac{1}{2} + z$; (iii) 1 - x, $y - \frac{1}{2}$, $\frac{3}{2} - z$.

All H atoms were positioned geometrically (C–H = 0.95–1.00 Å) and refined using a riding model, with the U_{iso} values for each H atom taken as $1.2U_{eq}$ of the carrier atom.

Data collection: COLLECT (Nonius, 1998); cell refinement: HKL SCALEPACK (Otwinowski & Minor, 1997); data reduction: HKL SCALEPACK and DENZO (Otwinowski & Minor, 1997); program(s) used to solve structure: SHELXS97 (Sheldrick, 1997); program(s) used to refine structure: SHELXL97 (Sheldrick, 1997); molecular graphics: XP (Sheldrick, 1993) and DIAMOND (Brandenburg, 1999); software used to prepare material for publication: SHELXL97.

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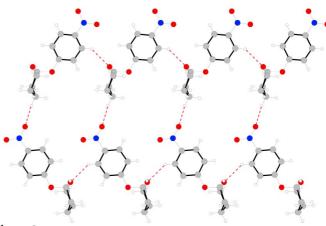
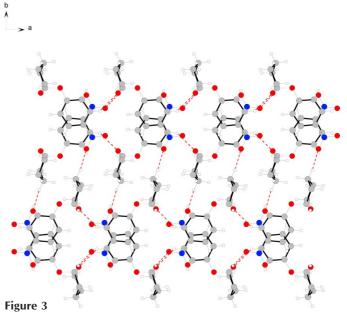


Figure 2

The two-dimensional supramolecular network formed by $C-H\cdots O$ hydrogen bonds (dashed lines) perpendicular to the *c* axis.



Projection on to (001), showing the two-dimensional networks stacking along the c axis.

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